onsemi

Silicon Carbide (SiC) Cascode JFET – EliteSiC, Power N-Channel, TO247-4, 1200 V, 35 mohm

UF3C120040K4S

Description

onsemi's cascode products co-package its high-performance F3 SiC fast JFETs with a cascode optimized MOSFET to produce the only standard gate drive SiC device in the market today. This series exhibits very fast switching using a 4-terminal TO247- package and the best reverse recovery characteristics of any device of similar ratings. These devices are excellent for switching inductive loads, and any application requiring standard gate drive.

Features

- Typical On-resistance $R_{DS(on)typ}$ of 35 m Ω
- Maximum Operating Temperature of 175 °C
- Excellent Reverse Recovery
- Low Gate Charge
- Low Intrinsic Capacitance
- ESD Protected, HBM Class 2
- TO247-4 Package for Faster Switching, Clean Gate Waveforms
- This Device is Pb-Free, Halogen Free and is ROHS Compliant

Typical Applications

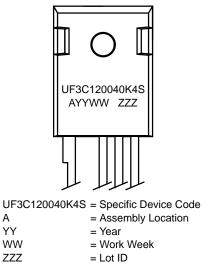
- EV Charging
- PV Inverters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Motor Drives
- Induction Heating

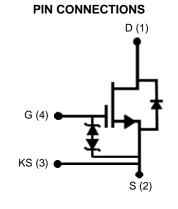
DATA SHEET www.onsemi.com



CASE 340AN

MARKING DIAGRAM





ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

MAXIMUM RATINGS

Parameter	Symbol	Test Conditions	Value	Unit
Drain-source Voltage	V _{DS}		1200	V
Gate-source Voltage	V _{GS}	DC	-25 to +25	V
Continuous Drain Current (Note 1)	Ι _D	T _C = 25 °C	65	А
		T _C = 100 °C	47	А
Pulsed Drain Current (Note 2)	I _{DM}	T _C = 25 °C	175	А
Single Pulsed Avalanche Energy (Note 3)	E _{AS}	L = 15 mH, I _{AS} = 4.2 A	132.3	mJ
Power Dissipation	P _{tot}	T _C = 25 °C	429	W
Maximum Junction Temperature	T _{J,max}		175	°C
Operating and Storage Temperature	T _J , T _{STG}		-55 to 175	°C
Max. Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	TL		250	°C

IIIStresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality
should not be assumed, damage may occur and reliability may be affected.1. Limited by $T_{J,max}$ 2. Pulse width t_p limited by $T_{J,max}$ 3. Starting $T_J = 25 \ ^{\circ}C$

THERMAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ extsf{ heta}JC}$		-	0.27	0.35	°C/W

ELECTRICAL CHARACTERISTICS (T_J = +25 °C unless otherwise specified)

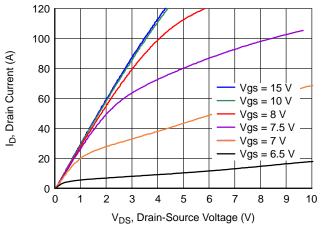
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
TYPICAL PERFORMANCE – STATIC	-					
Drain-source Breakdown Voltage	BV _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1200	-	-	V
Total Drain Leakage Current	I _{DSS}	V_{DS} = 1200 V, V_{GS} = 0 V, T_{J} = 25 $^{\circ}C$	-	8	150	μΑ
		V_{DS} = 1200 V, V_{GS} = 0 V, T_{J} = 175 $^{\circ}C$	-	35	-	
Total Gate Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, \text{ T}_{J} = 25 \text{ °C}, \ V_{GS} = -20 \text{ V} / +20 \text{ V}$	-	6	±20	μΑ
Drain-source On-resistance	R _{DS(on)}	V_{GS} = 12 V, I_{D} = 40 A, T_{J} = 25 $^{\circ}C$	-	35	45	mΩ
		V_{GS} = 12 V, I _D = 40 A, T _J = 125 °C	-	56	-	1
		V_{GS} = 12 V, I _D = 40 A, T _J = 175 °C	-	73	-	
Gate Threshold Voltage	V _{G(th)}	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 10 \text{ mA}$	4	5	6	V
Gate Resistance	R _G	f = 1 MHz, open drain	-	4.5	-	Ω
TYPICAL PERFORMANCE – REVERSE DIO	DE					
Diode Continuous Forward Current (Note 4)	۱ _S	$T_{C} = 25 \ ^{\circ}C$	-	-	65	А
Diode Pulse Current (Note 5)	I _{S,pulse}	$T_{C} = 25 \ ^{\circ}C$	-	-	175	А
Forward Voltage	V _{FSD}	V_{GS} = 0 V, I_S = 20 A, T_J = 25 $^\circ C$	-	1.5	2	V
		V_{GS} = 0 V, I _S = 20 A, T _J = 175 °C	-	1.95	-	
Reverse Recovery Charge	Q _{rr}	$V_{DS} = 800 \text{ V}, \text{ I}_{S} = 40 \text{ A}, \text{ V}_{GS} = -5 \text{ V},$	-	358	-	nC
Reverse Recovery Time	t _{rr}	$R_{G_{EXT}} = 10 \Omega$, di/dt = 2400 A/µs, T _J = 25 °C	-	25	-	ns
Reverse Recovery Charge	Q _{rr}	$V_{DS} = 800 \text{ V}, \text{ I}_{S} = 40 \text{ A}, \text{ V}_{GS} = -5 \text{ V},$	_	259	-	nC
Reverse Recovery Time	t _{rr}	R _{G_EXT} = 10 Ω, di/dt = 2400 A/μs, T _J = 150 °C	-	22	-	ns

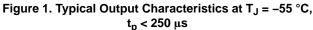
ELECTRICAL CHARACTERISTICS (T_J = +25 $^{\circ}$ C unless otherwise specified) (continued)

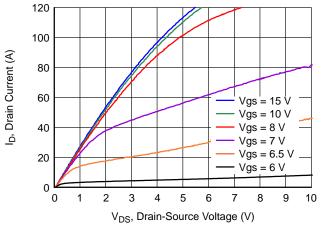
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
TYPICAL PERFORMANCE – DYNAMIC						
Input Capacitance	C _{iss}			1500	_	pF
Output Capacitance	C _{oss}	f = 100 kHz	-	210	-	
Reverse Transfer Capacitance	C _{rss}		-	1.7	-	
Effective Output Capacitance, Energy Related	C _{oss(er)}	V_{DS} = 0 V to 800 V, V_{GS} = 0 V	-	112	-	pF
Effective Output Capacitance, Time Related	C _{oss(tr)}	V_{DS} = 0 V to 800 V, V_{GS} = 0 V	-	280	-	pF
C _{OSS} Stored Energy	E _{oss}	$V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	-	35.6	-	μJ
Total Gate Charge	Q _G	$V_{DS} = 800 \text{ V}, \text{ I}_{D} = 40 \text{ A},$	-	43	-	nC
Gate-drain Charge	Q _{GD}	$V_{GS} = -5$ V to 12 V	-	11	-	
Gate-source Charge	Q _{GS}		-	19	-	
Turn-on Delay Time	t _{d(on)}	$ \begin{array}{l} V_{DS} = 800 \text{ V}, \text{ I}_{D} = 40 \text{ A}, \\ \text{Gate Driver} = -5 \text{ V to } +12 \text{ V}, \\ \text{Turn-on } \text{R}_{G,\text{EXT}} = 8.5 \ \Omega, \\ \text{Turn-off } \text{R}_{G,\text{EXT}} = 20 \ \Omega \\ \text{Inductive Load}, \\ \text{FWD: same device with } \text{V}_{\text{GS}} = -5 \text{ V}, \\ \text{R}_{\text{G}} = 10 \ \Omega, \ \text{T}_{\text{J}} = 25 \ ^{\circ}\text{C} \end{array} $	-	24	-	ns
Rise Time	tr		-	27	-	
Turn-off Delay Time	t _{d(off)}		-	50	-	
Fall Time	t _f		-	10	-	
Turn-on Energy	E _{ON}		-	780	-	μJ
Turn-off Energy	E _{OFF}		-	195	-	
Total Switching Energy	E _{TOTAL}		-	975	-	
Turn-on Delay Time	t _{d(on)}	$V_{DS} = 800 \text{ V}, I_{D} = 40 \text{ A},$	-	23	-	ns
Rise Time	t _r	Gate Driver = -5 V to +12 V, Turn-on R _{G.EXT} = 8.5 Ω ,	-	24	-	
Turn-off Delay Time	t _{d(off)}	Turn-off $R_{G,EXT} = 20 \Omega$ Inductive Load, FWD: same device with V _{GS} = -5 V,	-	50	-	
Fall Time	t _f		-	9	-	
Turn-on Energy	E _{ON}	- R _G = 10 Ω, T _J = 150 °C	-	668	-	μJ
Turn-off Energy	E _{OFF}		_	134	-	
Total Switching Energy	E _{TOTAL}	1	_	802	_	

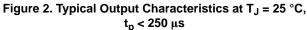
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Limited by T_{J,max}
5. Pulse width t_p limited by T_{J,max}

TYPICAL PERFORMANCE DIAGRAMS









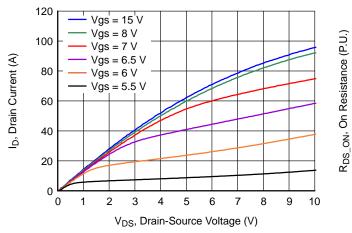
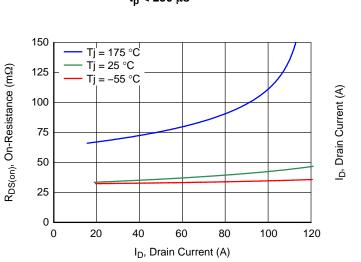
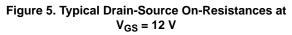


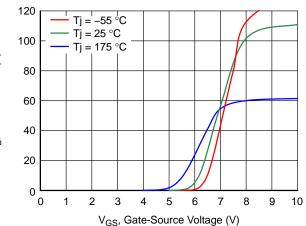
Figure 3. Typical Output Characteristics at T_J = 175 °C, $t_p < 250 \ \mu s$

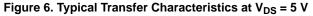




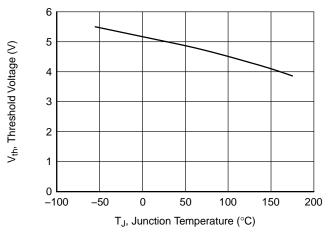
2.5 2.0 1.5 1.0 0.5 0.0 -75 -50 -25 0 25 50 75 100 125 150 175 T_J, Junction Temperature (°C)

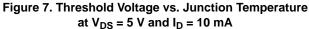
Figure 4. Normalized On-Resistance vs. Temperature at V_{GS} = 12 V and I_{D} = 40 A

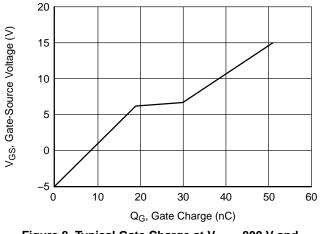


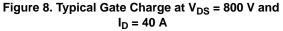


TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)









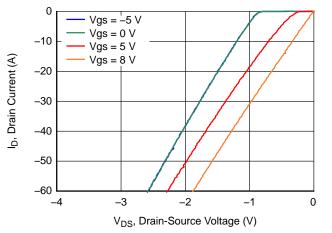


Figure 9. 3rd Quadrant Characteristics at $T_J = -55$ °C

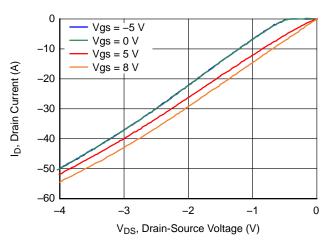


Figure 11. 3rd Quadrant Characteristics at $T_J = 175$ °C

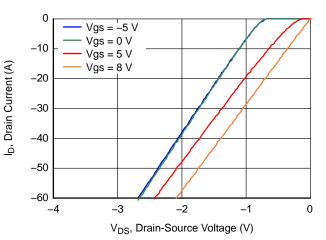
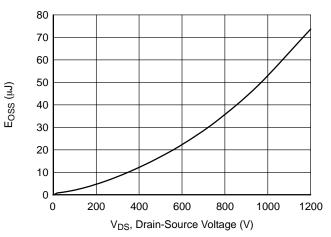
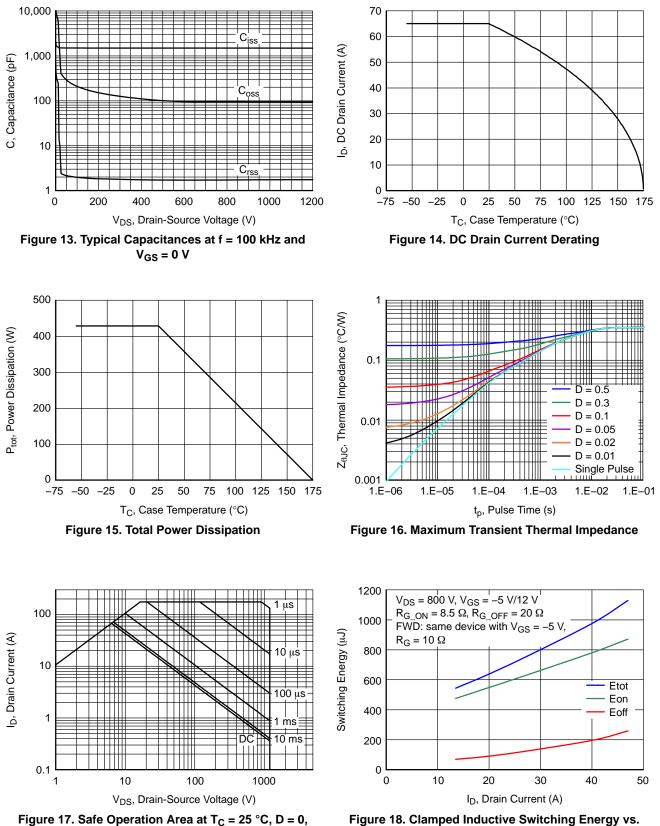


Figure 10. 3rd Quadrant Characteristics at T_J = 25 °C

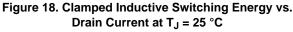




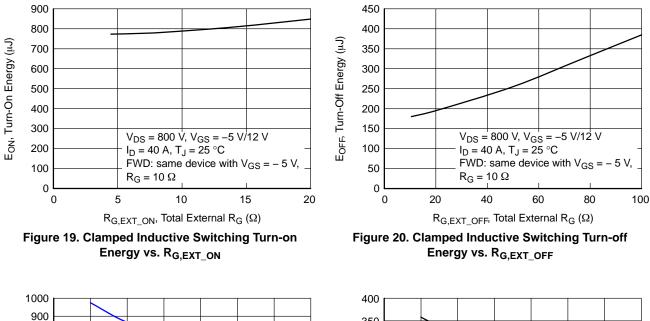
TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)



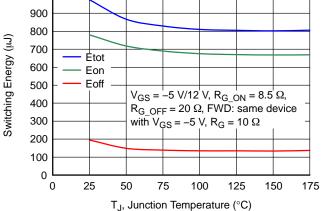
Parameter tp

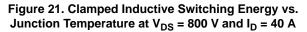


TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)



Q_{rr} (nC)





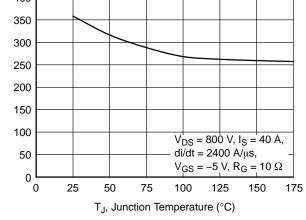


Figure 22. Reverse Recovery Charge Q_{rr} vs. Junction Temperature

APPLICATIONS INFORMATION

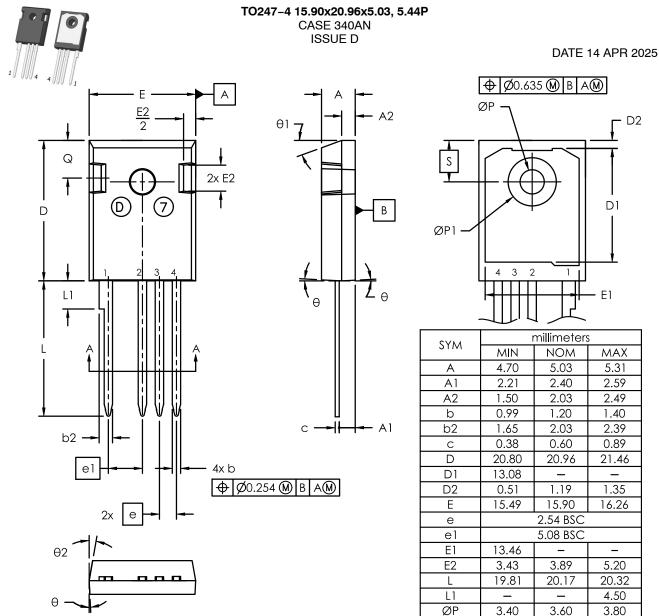
SiC cascodes are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{rr}) leading to low conduction and switching losses. The SiC cascodes also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the cascode is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on cascode operation, see <u>www.onsemi.com</u>.

ORDERING INFORMATION

Part Number	Marking	Package	Shipping [†]
UF3C120040K4S	UF3C120040K4S	TO247-4 15.90x20.96x5.03, 5.44P (Pb-Free, Halogen Free)	600 / Tube

nsemi



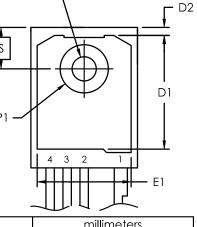
NOTE:

- 1. Dimensioning and tolerancing as per ASME Y14.5 2018
- 2. Controlling dimension : millimeters
- 3. Package Outline in compliance with JEDEC standard var. AD.
- Dimensions D & E does not include mold flash. 4.
- 5. ØP to have max draft angle of 1.7° to the top with max. hole diameter of 3.91mm.
- 5. Through Hole diameter value = End Hole diameter
- PCB Through Hole pattern as per IPC-2221/IPC-2222 6.

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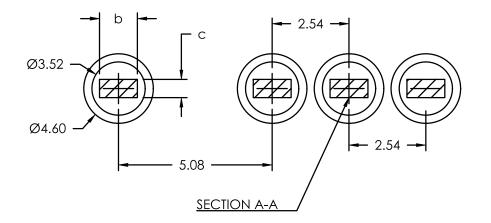
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SYM		millimeters				
3174	MIN	NOM	MAX			
А	4.70	5.03	5.31			
A1	2.21	2.40	2.59			
A2	1.50	2.03	2.49			
b	0.99	1.20	1.40			
b2	1.65	2.03	2.39			
С	0.38	0.60	0.89			
c D	20.80	20.96	21.46			
D1	13.08	-	-			
D2	0.51	1.19	1.35			
E	15.49	15.90	16.26			
е	2.54 BSC					
el		5.08 BSC				
E1	13.46	-	-			
E2	3.43	3.89	5.20			
L	19.81	20.17	20.32			
L1	1		4.50			
ØP	3.40	3.60	3.80			
ØP1	7.06	7.19	7.39			
Q	5.38	5.62	6.20			
S Đ	6.17 BSC					
θ		3°				
θ1		20°				
θ2		10°				

DATE 14 APR 2025

RECOMMENDED PCB THROUGH HOLE



NOTE: LAND PATTERN AND THROUGH HOLE DIMENSIONS SERVE ONLY AS AN INITIAL GUIDE. END-USER PCB DESIGN RULES AND TOLERANCES SHOULD ALWAYS PREVAIL.

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DESCRIPTION:	TO247-4 15.90x20.96x5.03, 5.44P		PAGE 2 OF 2	

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